# 5-V MULTICHANNEL RS-232 LINE DRIVER/RECEIVER WITH +15-kV FSD PROTECTION

SLLS592B - OCTOBER 2003 - REVISED JANUARY 2004

- ESD Protection for RS-232 I/O Pins
   ±15 kV Human-Body Model
- Meets or Exceeds the Requirements of TIA/EIA-232-F and ITU v.28 Standards
- Operates at 5-V V<sub>CC</sub> Supply
- Operates Up To 120 kbit/s
- External Capacitors . . . 4 × 0.1 μF
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- Applications
  - Battery-Powered Systems, PDAs,
     Notebooks, Laptops, Palmtop PCs, and Hand-Held Equipment

# DB OR DW PACKAGE (TOP VIEW)

DOUT3	1	J <sub>24</sub>	DOUT4
=	l '	24	
DOUT1 L	2	23	RIN2
DOUT2	3	22	ROUT2
RIN1	4	21	DIN5
ROUT1	5	20	DOUT5
DIN2	6	19	DIN4
DIN1 [	7	18	DIN3
GND [	8	17	ROUT3
v <sub>cc</sub> [	9	16	RIN3
C1+ [	10	15	] V-
V+ [	11	14	] C2-
C1- [	12	13	C2+

## description/ordering information

The MAX207 consists of five line drivers, three line receivers, and a dual charge-pump circuit with ±15-kV ESD protection pin to pin (serial-port connection pins, including GND). The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 5-V supply. The devices operate at data signaling rates up to 120 kbit/s and a maximum of 30-V/μs driver output slew rate.

#### ORDERING INFORMATION

TA	PACKAGE <sup>†</sup>		PACKAGET ORDERABLE PART NUMBER			TOP-SIDE MARKING
	0010 (DW)	Tube of 25	MAX207CDW	MAYOOZO J. B.C.		
0°C to 70°C	SOIC (DW)	Reel of 2000	MAX207CDWR	MAX207C		
	SSOP (DB)	Reel of 2000	MAX207CDBR	MA207C		
	0010 (DW)	Tube of 25	MAX207IDW	MANOO71		
-40°C to 85°C	SOIC (DW)	Reel of 2000	MAX207IDWR	MAX207I		
	SSOP (DB)	Reel of 2000	MAX207IDBR	MB207I		

Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



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### **Function Tables**

### **EACH DRIVER**

INPUT DIN	OUTPUT DOUT
L	Н
Н	L

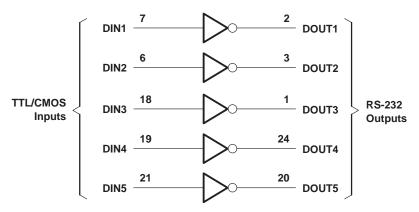
H = high level, L = low level

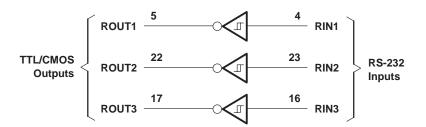
### **EACH RECEIVER**

INPUT R <sub>IN</sub>	OUTPUT ROUT
L	Н
Н	L
Open	Н

 $\begin{array}{lll} H = high \ level, \ L = low \\ level, \ Open = input \\ disconnected & or \\ connected \ driver \ off \end{array}$ 

## logic diagram (positive logic)







## MAX207 5-V MULTICHANNEL RS-232 LINE DRIVER/RECEIVER WITH +15-kV ESD PROTECTION

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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub> (see Note 1)	to 6 V
Positive charge pump voltage range, V+ (see Note 1)	o 14 V
Negative charge pump voltage range, V- (see Note 1)14 V to	0.3 V
Input voltage range, V <sub>I</sub> : Drivers	+ 0.3 V
Receivers	±30 V
Output voltage range, V <sub>O</sub> : Drivers V– – 0.3 V to V+ ·	+ 0.3 V
Receivers0.3 V to V <sub>CC</sub> ·	+ 0.3 V
Short-circuit duration: D <sub>OUT</sub>	inuous
Package thermal impedance, θ <sub>JA</sub> (see Notes 2 and 3): DB package	3°C/W
DW package4	6°C/W
Operating virtual junction temperature, T <sub>J</sub>	150°C
Storage temperature range, T <sub>stg</sub> –65°C to	150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltages are with respect to network GND.
  - 2. Maximum power dissipation is a function of  $T_J(max)$ ,  $\theta_{JA}$ , and  $T_A$ . The maximum allowable power dissipation at any allowable ambient temperature is  $P_D = (T_J(max) T_A)/\theta_{JA}$ . Operating at the absolute maximum  $T_J$  of 150°C can affect reliability.
  - 3. The package thermal impedance is calculated in accordance with JESD 51-7.

## recommended operating conditions (see Note 4 and Figure 4)

			MIN	NOM	MAX	UNIT
	Supply voltage		4.5	5	5.5	V
VIH	Driver high-level input voltage	D <sub>IN</sub>	2			٧
V <sub>IL</sub>	Driver low-level input voltage	D <sub>IN</sub>			0.8	V
\/.	Driver input voltage	D <sub>IN</sub>	0		5.5	V
VI	Receiver input voltage	_	-30		30	V
Τ.	Operating free dir temperature	MAX207C	0		70	°C
TA	Operating free-air temperature	MAX207I	-40		85	-0

NOTE 4: Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.

# electrical characteristics over recommended ranges of supply voltage (unless otherwise noted) (see Note 4 and Figure 4)

	PARAMETER	TEST CONDITIONS			MIN	TYP	MAX	UNIT
ICC	Supply current	No load,	V <sub>CC</sub> = 5 V,	T <sub>A</sub> = 25°C		11	20	mA

NOTE 4: Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.



## **MAX207**

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### **DRIVER SECTION**

# electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Note 4 and Figure 4)

PARAMETER		TEST CONDITIONS			TYP†	MAX	UNIT
Vон	High-level output voltage	D <sub>OUT</sub> at R <sub>L</sub> = 3 k $\Omega$ to GND,	D <sub>IN</sub> = GND	5	9		V
VOL	Low-level output voltage	$D_{OUT}$ at $R_L = 3 \text{ k}\Omega$ to GND,	$D_{IN} = V_{CC}$	-5	-9		V
lн	High-level input current	VI = VCC			15	200	μΑ
Ι <sub>Ι</sub> L	Low-level input current	V <sub>I</sub> at 0 V			-15	-200	μΑ
los‡	Short-circuit output current	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 0 V		±10	±60	mA
r <sub>O</sub>	Output resistance	$V_{CC}$ , V+, and V- = 0 V,	V <sub>O</sub> = ±2 V	300		·	Ω

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC} = 5$  V, and  $T_A = 25$ °C.

NOTE 4: Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.

# switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Note 4 and Figure 4)

	PARAMETER TEST CONDITIONS		MIN	TYP†	MAX	UNIT	
	Maximum data rate	C <sub>L</sub> = 50 to 1000 pF, One D <sub>OUT</sub> switching,	$R_L$ = 3 kΩ to 7 kΩ, See Figure 1	120			kbit/s
<sup>t</sup> PLH (D)	Propagation delay time, low- to high-level output	C <sub>L</sub> = 2500 pF, all drivers loaded,	$R_L = 3 \text{ k}\Omega$ , See Figure 1		2		μs
<sup>†</sup> PHL (D)	Propagation delay time, high- to low-level output	C <sub>L</sub> = 2500 pF, all drivers loaded,	$R_L = 3 \text{ k}\Omega$ , See Figure 1		2		μs
t <sub>sk(p)</sub>	Pulse skew§	$C_L = 150 \text{ pF to } 2500 \text{ pF},$	$R_L$ = 3 kΩ to 7 kΩ, See Figure 2		300		ns
SR(tr)	Slew rate, transition region (see Figure 1)	C <sub>L</sub> = 50 pF to 1000 pF V <sub>CC</sub> = 5 V	$R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega,$	3	6	30	V/µs

 $<sup>\</sup>overline{\dagger}$  All typical values are at  $V_{CC} = 5$  V, and  $T_A = 25$ °C.

NOTE 4: Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.

### **ESD** protection

PIN	TEST CONDITIONS	TYP	UNIT
D <sub>OUT</sub> , R <sub>IN</sub>	Human-Body Model	±15	kV



<sup>\$</sup> Short-circuit durations should be controlled to prevent exceeding the device absolute power-dissipation ratings, and not more than one output should be shorted at a time.

<sup>§</sup> Pulse skew is defined as |tpLH - tpHL| of each channel of the same device.

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### **RECEIVER SECTION**

# electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Note 4 and Figure 4)

PARAMETER		TEST COND	TEST CONDITIONS		TYP <sup>†</sup>	MAX	UNIT
Vон	High-level output voltage	$I_{OH} = -1 \text{ mA}$		3.5	V <sub>CC</sub> -0.4 V		V
VOL	Low-level output voltage	I <sub>OL</sub> = 1.6 mA				0.4	V
V <sub>IT+</sub>	Positive-going input threshold voltage	$V_{CC} = 5 V$ ,	T <sub>A</sub> = 25°C		1.7	2.4	V
VIT-	Negative-going input threshold voltage	$V_{CC} = 5 V$ ,	T <sub>A</sub> = 25°C	0.8	1.2		V
V <sub>hys</sub>	Input hysteresis (V <sub>IT+</sub> - V <sub>IT-</sub> )			0.2	0.5	1	V
rį	Input resistance	$V_I = \pm 3 \text{ V to } \pm 25 \text{ V}$		3	5	7	kΩ

 $<sup>\</sup>overline{\dagger}$  All typical values are at V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

NOTE 4: Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.

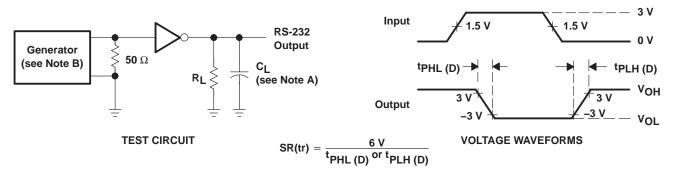
# switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Note 4 and Figure 3)

	PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	UNIT
tPLH	Propagation delay time, low- to high-level output	0 450 - 5		0.5	10	μs
tPHL	Propagation delay time, high- to low-level output	C <sub>L</sub> = 150 pF		0.5	10	μs
tsk(p)	Pulse skew <sup>‡</sup>			300		ns

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC} = 5$  V, and  $T_A = 25$ °C.

NOTE 4: Test conditions are C1–C4 = 0.1  $\mu$ F, at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.

### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 120 kbit/s,  $Z_O = 50 \Omega$ , 50% duty cycle,  $t_\Gamma \le 10$  ns.  $t_f \le 10$  ns.

Figure 1. Driver Slew Rate



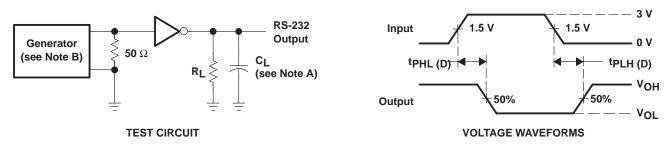
<sup>‡</sup> Pulse skew is defined as |tpLH - tpHL| of each channel of the same device.

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WITH ±15-KV ESD PROTECTION

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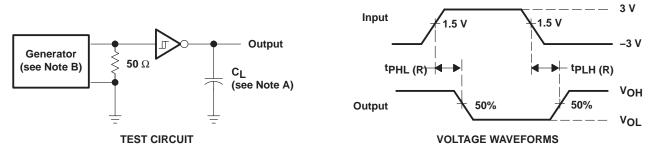
### PARAMETER MEASUREMENT INFORMATION



NOTES: A.  $C_L$  includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 120 kbit/s,  $Z_O = 50 \Omega$ , 50% duty cycle,  $t_f \le 10$  ns.  $t_f \le 10$  ns.

Figure 2. Driver Pulse Skew

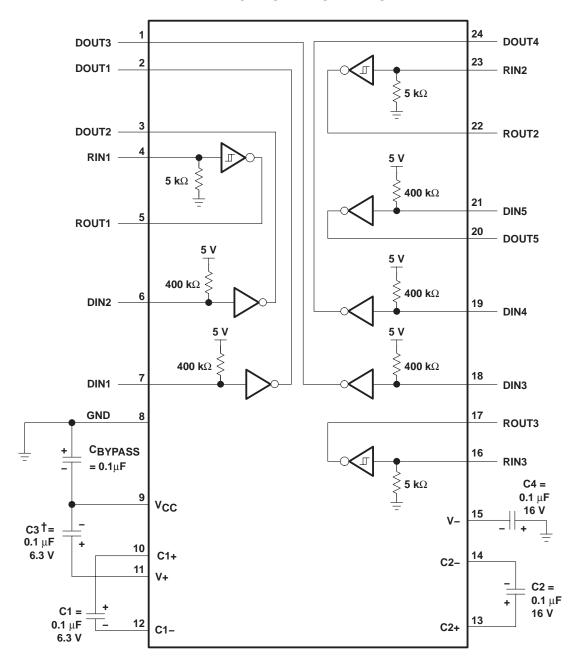


NOTES: A. CL includes probe and jig capacitance.

B. The pulse generator has the following characteristics:  $Z_0 = 50 \Omega$ , 50% duty cycle,  $t_r \le 10$  ns,  $t_f \le 10$  ns.

Figure 3. Receiver Propagation Delay Times

### **APPLICATION INFORMATION**



†C3 can be connected to VCC or GND.

NOTES: A. Resistor values shown are nominal.

B. Nonpolarized ceramic capacitors are acceptable. If polarized tantalum or electrolytic capacitors are used, they should be connected as shown.

Figure 4. Typical Operating Circuit and Capacitor Values



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#### APPLICATION INFORMATION

### capacitor selection

The capacitor type used for C1–C4 is not critical for proper operation. The MAX207 requires 0.1- $\mu$ F capacitors, although capacitors up to 10  $\mu$ F can be used without harm. Ceramic dielectrics are suggested for the 0.1- $\mu$ F capacitors. When using the minimum recommended capacitor values, make sure the capacitance value does not degrade excessively as the operating temperature varies. If in doubt, use capacitors with a larger (e.g., 2×) nominal value. The capacitors' effective series resistance (ESR), which usually rises at low temperatures, influences the amount of ripple on V+ and V-.

Use larger capacitors (up to 10  $\mu$ F) to reduce the output impedance at V+ and V-.

Bypass  $V_{CC}$  to ground with at least 0.1  $\mu$ F. In applications sensitive to power-supply noise generated by the charge pumps, decouple  $V_{CC}$  to ground with a capacitor the same size as (or larger than) the charge-pump capacitors (C1–C4).

### **ESD** protection

TI MAX207 devices have standard ESD protection structures incorporated on the pins to protect against electrostatic discharges encountered during assembly and handling. In addition, the RS232 bus pins (driver outputs and receiver inputs) of these devices have an extra level of ESD protection. Advanced ESD structures were designed to successfully protect these bus pins against ESD discharge of ±15-kV when powered down.

### **ESD** test conditions

ESD testing is stringently performed by TI, based on various conditions and procedures. Please contact TI for a reliability report that documents test setup, methodology, and results.

### **Human-Body Model**

The Human-Body Model (HBM) of ESD testing is shown in Figure 5, while Figure 6 shows the current waveform that is generated during a discharge into a low impedance. The model consists of a 100-pF capacitor, charged to the ESD voltage of concern, and subsequently discharged into the device under test (DUT) through a 1.5-k $\Omega$  resistor.

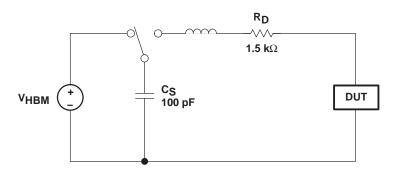


Figure 5. HBM ESD Test Circuit



### **APPLICATION INFORMATION**

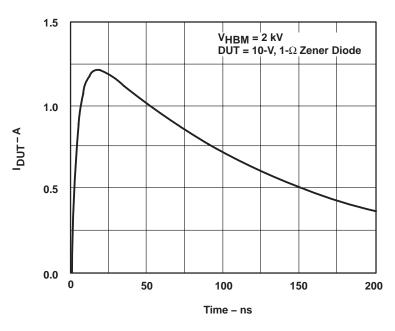


Figure 6. Typical HBM Current Waveform

### **Machine Model**

The Machine Model (MM) ESD test applies to all pins using a 200-pF capacitor with no discharge resistance. The purpose of the MM test is to simulate possible ESD conditions that can occur during the handling and assembly processes of manufacturing. In this case, ESD protection is required for all pins, not just RS-232 pins. However, after PC board assembly, the MM test no longer is as pertinent to the RS-232 pins.





### PACKAGE OPTION ADDENDUM

18-Jul-2006

### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp (3)
MAX207CDB	ACTIVE	SSOP	DB	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX207CDBE4	ACTIVE	SSOP	DB	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX207CDBR	ACTIVE	SSOP	DB	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX207CDBRE4	ACTIVE	SSOP	DB	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX207CDW	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX207CDWE4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX207CDWR	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX207CDWRE4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX207IDB	ACTIVE	SSOP	DB	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX207IDBE4	ACTIVE	SSOP	DB	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX207IDBR	ACTIVE	SSOP	DB	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX207IDBRE4	ACTIVE	SSOP	DB	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX207IDW	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX207IDWE4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX207IDWR	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX207IDWRE4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

<sup>&</sup>lt;sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): Tl's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.



## PACKAGE OPTION ADDENDUM

18-Jul-2006

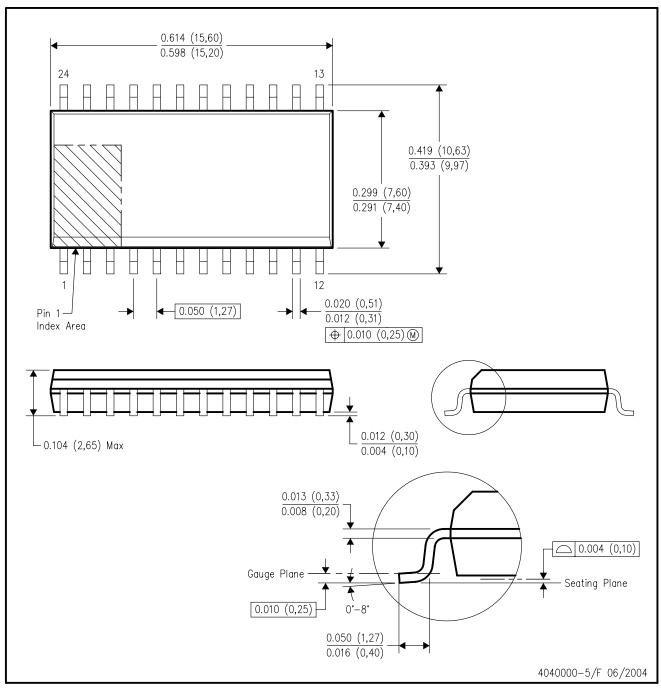
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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# DW (R-PDSO-G24)

# PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

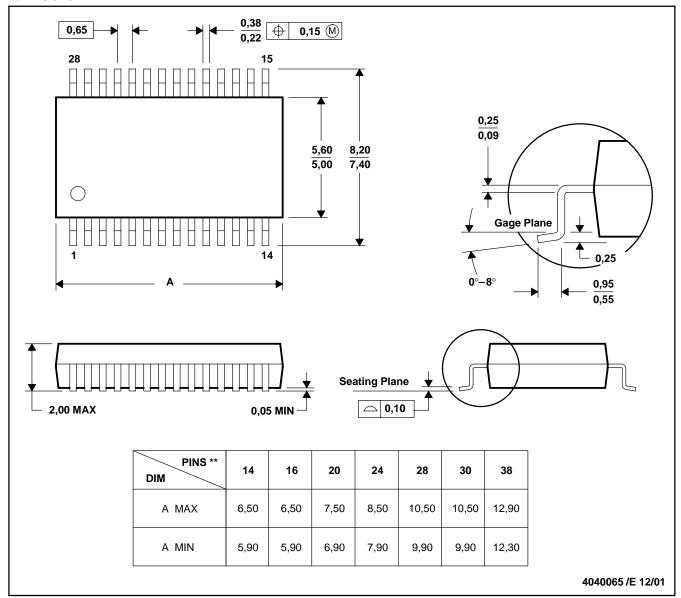
- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



## DB (R-PDSO-G\*\*)

### **PLASTIC SMALL-OUTLINE**

### **28 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



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